Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/711,637	CHEN ET AL.
Examiner	Art Unit
Tsz K. Chiu	2822

SEARCHED				
Class	Subclass	Date	Examiner	
257	288	7/10/2006	тс	
			:	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
257	66,72,347	7/10/2006	тс	
257	616,192	7/10/2006	TC	
Interferer	nce search	7/10/2006	TC	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (text search see attach)	7/10/2006	тс
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